

Industrial pSLC NAND M.2 2260 SSD

MDB550S SERIES

SATA III 6.0 Gbit/s

SLC Cache pSLC NAND



PRODUCT FEATURES

- pSLC Flash Technology
- · Global Wear Leveling and Early weak block retirement
- TRIM, NCQ, DEVSLP, ATA Security Feature Set supported
- Lifetime Enhancements
- Direct-to-TLC and SLC Cache enhancement to ensure the optimized WAF
- Block/Page RAID function to ensure data recovery
- StaticDataRefresh to keep data integrity
- Reliable Industrial grade integrated Active PMU and complete protection design with OVP, OCP, Surge rejection and Short protection
- External DRAM to achieve the optimal sustained read/write performance
- · Power shielding firmware architecture to ensure power failure resilience
- AES256 Encryption and TCG Opal 2.0 compliant (by request)
- SP SMART Toolbox
- SP SMART Embedded and SMART IoT service (by request)

PRODUCT SUMMARY

- · Capacities: 64GB, 128GB
- Form Factor: M.2 2260 SATA Solid State Drive (60 mm x 22 mm x 3.5 mm)
- · Compliance: SATA Revision 3.1 6 Gbit/s (3 Gbit/s and 1.5 Gbit/s backward compatible)
- Command Sets: Supports ATA/ATAPI-8 and ACS-2
- · Performance:

	64GB	128GB	
Sequential Read (MB/s max.)	520	520	
Sequential Write (MB/s max.)	480	480	
Random 4K Read (IOPS max.)	78000	75000	
Random 4K Write (IOPS max.)	54000	86000	

^{*}Actual performance may vary based on the specific model and capacity

· Operating Temperature Range:

Normal: 0 °C to 70 °C

Extended: -15 $^{\circ}$ C to 85 $^{\circ}$ C (by request) Wide: -40 $^{\circ}$ C to 85 $^{\circ}$ C (by request)

Storage Temperature Range: -55 °C to 95 °C

• Operating Voltage: 3.3 V \pm 10%

Power Consumption :

Unit: mA	64GB	128GB	
Read (active)	510	520	
Write (active)	565	580	
Stand-by	110	110	

(Unit: mA)

- Data Retention @40 °C: 10 Years @ Life Begin; 1 Year @ Life End
- Endurance in Tera Bytes Written (TBW)

TBW is estimated by formula TBW= (Capacity \times PE Cycles)/ (WAF \times 2). Assumption of guard band for the wear leveling is 2.

	64GB	128GB	
TBW (guard band factor 2)	935.6	1871.2	

(Unit: TB)

Mechanical (IEC-60068):

Vibration: 15G, 10 ~ 2001Hz

Drop: 76cm

Shock: 1,500G@0.6ms

- LDPC ECC with up to 120 bit correction per 1 KByte page to ensure reliable 30K PE cycles
- Mean Time Between Failure: > 2,000,000 hours
- Data Reliability: Non-recover Read (UBER) ≤10⁻¹⁶
- Serious quality control and assurance
 - 100% NAND Flash screening
 - High endurance product design with 3D NAND and pSLC product offerings
 - Implement high/low temperature dynamic burn-in in each lot production to monitor production quality to meet design specification
 - Reliability criteria compliant with international standards IEC-60068/61000



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^{*} Information might be changed or updated without notice.